

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

OptiMOS[™]

OptiMOS[™] Power-MOSFET, 30 V IPT004N03L

Data Sheet

Rev. 2.0 Final





IPT004N03L

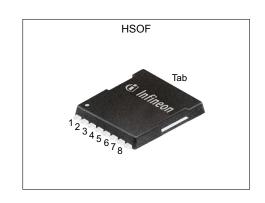
1 **Description**

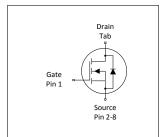
Features

- · Optimized for e-fuse and ORing application
- Very low on-resistance $R_{\rm DS(on)}$ @ $V_{\rm GS}$ =4.5 V
- 100% avalanche tested
- Superior thermal resistance
- N-channel
- Qualified according to JEDEC¹⁾ for target applications
 Pb-free lead plating; RoHS compliant



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Parameter	Value	Unit					
V _{DS}	30	V					
R _{DS(on),max}	0.4	mΩ					
I_{D}	300	A					
Qoss	141	nC					
Q _G (0V10V)	252	nC					











Type / Ordering Code	Package	Marking	Related Links
IPT004N03L	PG-HSOF-8-1	004N03L	-



OptiMOS[™] Power-MOSFET, 30 V

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2 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 at 25 °C **Maximum ratings**

Danamatan	Symbol	Values				
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I _D	- - - -	- - - -	300 300 300 300 72	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =4.5 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =4.5 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =40 K/W ¹⁾
Pulsed drain current ²⁾	I _{D,pulse}	-	-	1200	Α	<i>T</i> _C =25 °C
Avalanche energy, single pulse ³⁾	E AS	-	-	830	mJ	I _D =150 A
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	300 3.8	W	T _C =25 °C T _A =25 °C, R _{thJA} =40 K/W ¹⁾
Operating and storage temperature	T _j , T _{stg}	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

3 Thermal characteristics

Table 3 Thermal characteristics

Davamatav	Cumbal	Values			Linit	Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	-	0.5	K/W	-
Device on PCB	R _{thJA}	-	-	40 62	K/W	6 cm² cooling area ¹⁾ minimum footprint

 $^{^{1)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air. $^{2)}$ See figure 3 for more detailed information $^{3)}$ See figure 13 for more detailed information



4 Electrical characteristics

Table 4 Static characteristics

Davamatar	Symbol		Values			Note / Took Condition
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	$V_{(BR)DSS}$	30	-	-	V	V _{GS} =0 V, I _D =10 mA
Gate threshold voltage	V _{GS(th)}	0.7	-	2.2	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=250\ \mu{\rm A}$
Zero gate voltage drain current	I _{DSS}	-	0.1 10	10 100	μA	V _{DS} =30 V, V _{GS} =0 V, T _j =25 °C V _{DS} =30 V, V _{GS} =0 V, T _j =125 °C
Gate-source leakage current	I _{GSS}	-	10	100	nA	V _{GS} =20 V, V _{DS} =0 V
Drain-source on-state resistance	R _{DS(on)}	-	0.44 0.37	0.5 0.4	mΩ	V _{GS} =4.5 V, I _D =150 A V _{GS} =10 V, I _D =150 A
Gate resistance	R _G	1.4	2.7	5.4	Ω	-
Transconductance	g fs	160	320	-	S	$ V_{DS} > 2 I_D R_{DS(on)max}, I_D = 30 A$

 Table 5
 Dynamic characteristics

Parameter	Cumbal	Values			11	Note / Took Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	C _{iss}	-	18000	24000	pF	V _{GS} =0 V, V _{DS} =15 V, <i>f</i> =1 MHz
Output capacitance	Coss	-	5400	7200	pF	V _{GS} =0 V, V _{DS} =15 V, <i>f</i> =1 MHz
Reverse transfer capacitance	C _{rss}	-	590	-	pF	V _{GS} =0 V, V _{DS} =15 V, <i>f</i> =1 MHz
Turn-on delay time	t _{d(on)}	-	30	-	ns	$V_{\rm DD}$ =15 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω
Rise time	t _r	-	17	-	ns	$V_{\rm DD}$ =15 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω
Turn-off delay time	$t_{ m d(off)}$	-	149	-	ns	$V_{\rm DD}$ =15 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω
Fall time	t _f	-	37	_	ns	$V_{\rm DD}$ =15 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω

Table 6 Gate charge characteristics¹⁾

Parameter	Symbol	Values			11!4	Note / Took Condition
		Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	40	53	nC	V_{DD} =15 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Gate charge at threshold	Q _{g(th)}	-	29	-	nC	V_{DD} =15 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Gate to drain charge	Q_{gd}	-	28	36	nC	V_{DD} =15 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Switching charge	Q _{sw}	-	38	-	nC	V_{DD} =15 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Gate charge total	Q_g	-	122	163	nC	V_{DD} =15 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Gate plateau voltage	V _{plateau}	-	2.2	-	V	V_{DD} =15 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Gate charge total	Q_g	-	252	336	nC	V_{DD} =15 V, I_{D} =30 A, V_{GS} =0 to 10 V
Gate charge total, sync. FET	Q _{g(sync)}	-	105	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 4.5 V
Output charge	Qoss	-	141	188	nC	V _{DD} =15 V, V _{GS} =0 V

¹⁾ See "Gate charge waveforms" for parameter definition



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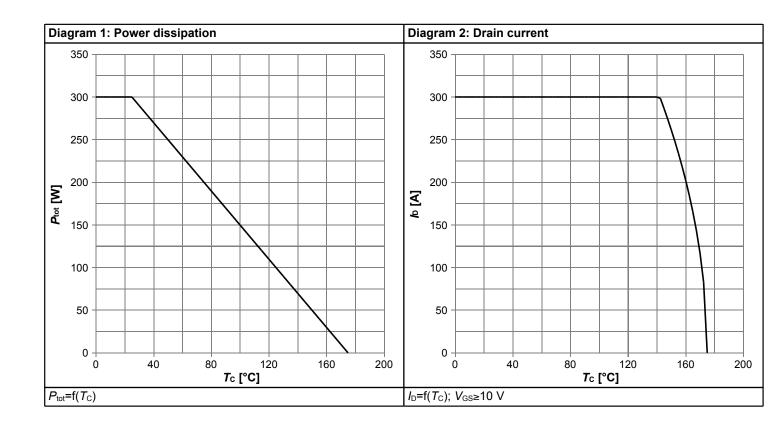
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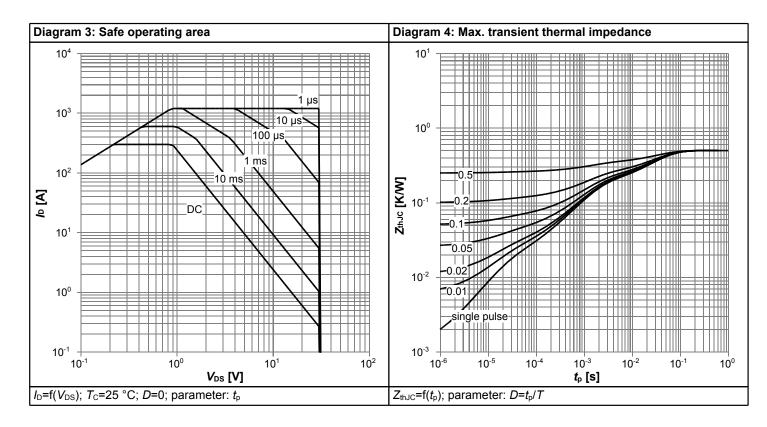
Table 7 Reverse diode

Parameter	Symbol		Values	;	I I m i 4	Note / Test Condition
		Min.	Тур.	Max.	Unit	
Diode continuous forward current	I _S	-	-	300	Α	<i>T</i> _C =25 °C
Diode pulse current	I _{S,pulse}	-	-	1200	Α	<i>T</i> _C =25 °C
Diode forward voltage	V _{SD}	-	0.83	1	V	V _{GS} =0 V, I _F =150 A, T _j =25 °C
Reverse recovery charge	Qrr	-	100	-	nC	V _R =15 V, I _F =100 A, d <i>i</i> _F /d <i>t</i> =400 A/μs

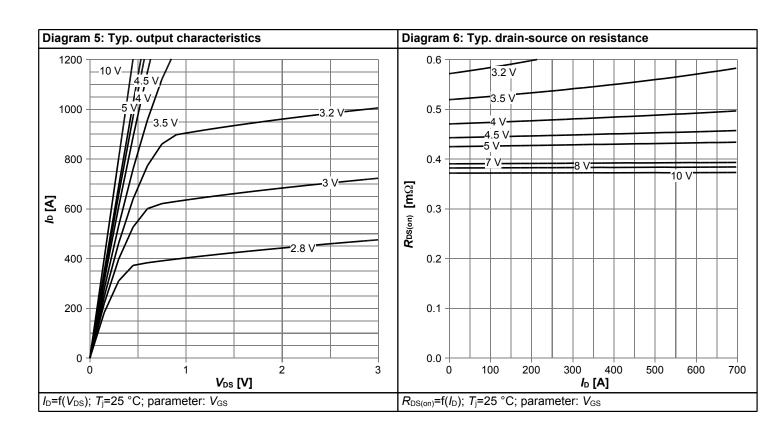


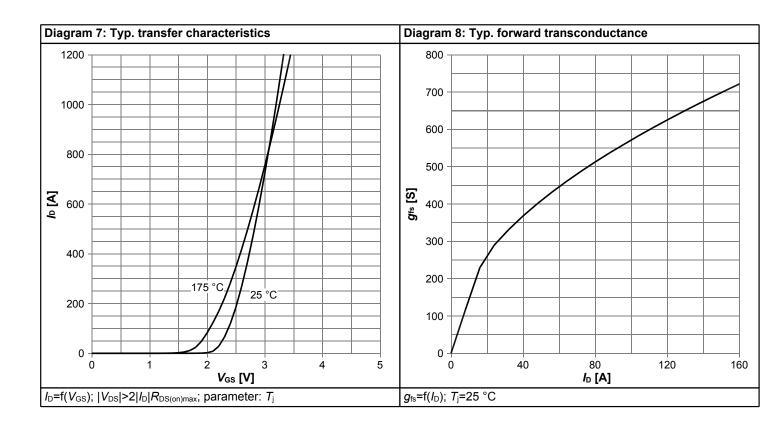
5 Electrical characteristics diagrams



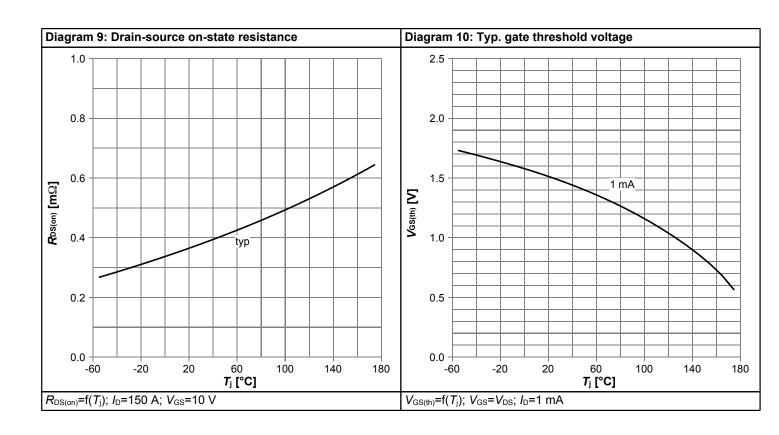


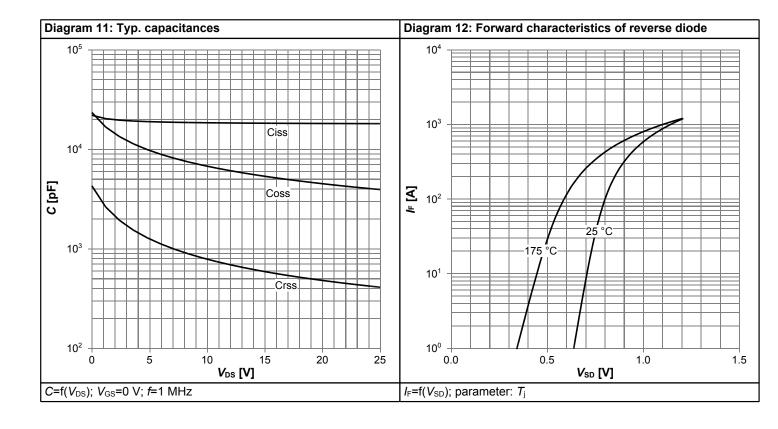




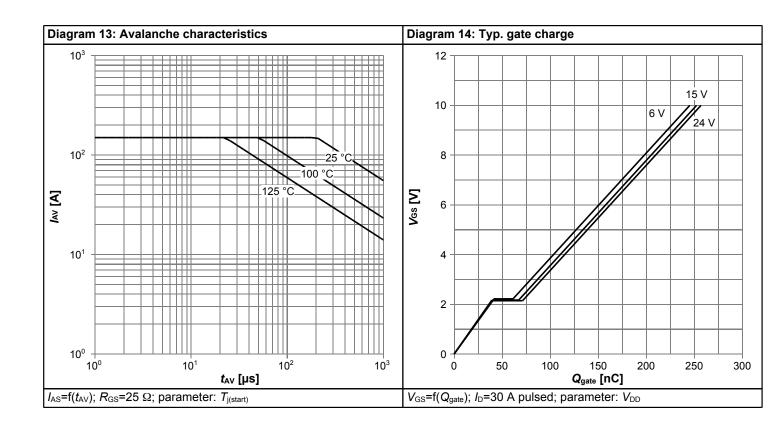


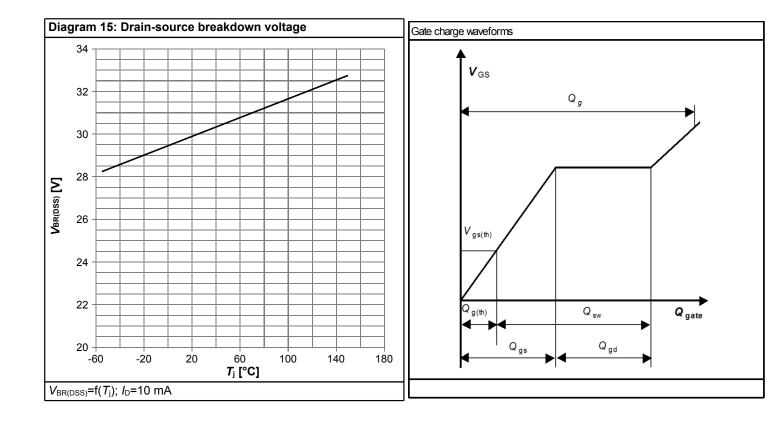














6 Package Outlines

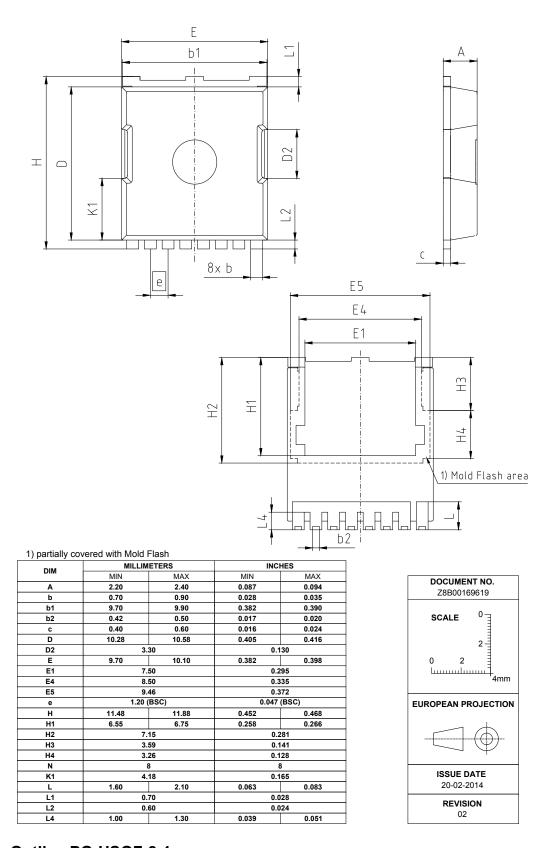


Figure 1 Outline PG-HSOF-8-1



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Revision History

IPT004N03L

Revision: 2014-10-08, Rev. 2.0

Revision. 2014-10-06, Rev

Previous Revision							
Revision	Date	Subjects (major changes since last revision)					
2.0	2014-10-08	Release of final version					

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